

Notice of References Cited	Application/Control No. 10/660,122	Applicant(s)/Patent Under Reexamination ECKER ET AL.	
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U.S. PATENT DOCUMENTS

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	U	Figueiredo et al (Am. J. Trop. Med. Hyg. (1998) 59(3):357-362).
	V	Fujioka et al (J. Virol. Meth. (1995) 51:253-258).
	W	Jurinke et al (Genetic Analysis: Biomolecular Engineering (1996) 13:67-71).
	X	Campbell et al (J. Virol. Methods (1996) 57:175-179).

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	V	BLAST Search results (03/2006)
	W	
	X	

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